

**Notice of References Cited**

Application/Control No.

10/031,349

Applicant(s)/Patent Under  
Reexamination  
YAMAMURA ET AL.

Examiner

Kevin L McHenry

Art Unit

1725

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,887,662	12-1989	Tanaka et al.	164/427
	B	US-6,491,089	12-2002	Poirier et al.	164/480
	C	US-6,431,256	08-2002	Ferretti et al.	164/428
	D	US-5,227,251	07-1993	Suichi et al.	428/687
	E	US-5,368,088	11-1994	Furuya et al.	164/415
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-06328204-A	11-1994	Japan	Mizuchi et al.	--
	O	JP-09103849-A	04-1997	Japan	Arai et al.	--
	P	JP-05261487-A	10-1993	Japan	Fukuda et al.	--
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.